



Shenzhen Global Test Service Co.,Ltd.

No.7-101 and 8A-104, Building 7 and 8, DCC Cultural and Creative Garden, No.98, Pingxin North Road,
Shangmugu Community, Pinghu Street, Longgang District, Shenzhen, Guangdong

FCC PART 27 TEST REPORT

FCC Part 27

Report Reference No.....: GTS20191021009-1-1-9

FCC ID.....: 2AURV-DIGICELDL3

Compiled by

(position+printed name+signature)..: File administrators Jimmy Wang

Supervised by

(position+printed name+signature)..: Test Engineer Aaron Tan

Approved by

(position+printed name+signature)..: Manager Jason Hu

Date of issue.....: Oct.25,2019

Representative Laboratory Name .: Shenzhen Global Test Service Co.,Ltd.

Address.....: No.7-101 and 8A-104, Building 7 and 8, DCC Cultural and Creative Garden, No.98, Pingxin North Road, Shangmugu Community, Pinghu Street, Longgang District, Shenzhen, Guangdong

Applicant's name.....: BOPEL MOBILE TECHNOLOGY CO., LIMITED

Address: Room A205, 2nd Floor, R2-B Building, Hi-tech Industrial Park , Gaoxin south 7 road, Nanshan District, Shenzhen

Test specification

Standard: **FCC CFR Title 47 Part 2, Part 27**

Shenzhen Global Test Service Co.,Ltd. All rights reserved.

This publication may be reproduced in whole or in part for non-commercial purposes as long as the Shenzhen Global Test Service Co.,Ltd. as copyright owner and source of the material. Shenzhen Global Test Service Co.,Ltd.takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.

Test item description Smart Phone

Trade Mark: Digicel

Manufacturer.....: BOPEL MOBILE TECHNOLOGY CO., LIMITED

Model/Type reference.....: DL3

Listed Models: N/A

Modulation Type.....: QPSK, 16QAM

LTE Band 2.....: 704~716 MHz

ANT Gain.....: 3.90dBi

Rating: DC 3.80V

Hardware version: J517C_63_32EMB_D3EFV1.1

Software version: Digicel_DL3_V3.0_10172019

Result.....: **PASS**

Jimmy Wang



Jason Hu

TEST REPORT

Test Report No. :	GTS20191021009-1-1-9	Oct.25,2019
		Date of issue

Equipment under Test : Smart Phone

Model /Type : DL3

Listed Models : N/A

Applicant : **BOPEL MOBILE TECHNOLOGY CO., LIMITED**

Address : Room A205, 2nd Floor, R2-B Building, Hi-tech Industrial Park , Gaoxin south 7 road, Nanshan District, Shenzhen

Manufacturer : **BOPEL MOBILE TECHNOLOGY CO., LIMITED**

Address : Room A205, 2nd Floor, R2-B Building, Hi-tech Industrial Park , Gaoxin south 7 road, Nanshan District, Shenzhen

Test Result:	PASS
---------------------	-------------

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

Contents

<u>1.</u>	<u>TEST STANDARDS</u>	<u>4</u>
<u>2.</u>	<u>SUMMARY</u>	<u>4</u>
2.1.	General Remarks	5
2.2.	Equipment under Test	5
2.3.	Short description of the Equipment under Test (EUT)	5
2.4.	EUT configuration	5
2.5.	Related Submittal(s) / Grant (s)	5
2.6.	Modifications	5
2.7.	Test Environment	5
<u>3.</u>	<u>TEST ENVIRONMENT.....</u>	<u>6</u>
3.1.	Address of the test laboratory	6
3.2.	Test Facility	6
3.3.	Environmental conditions	6
3.4.	Test Description	6
3.5.	Equipments Used during the Test	7
<u>4.</u>	<u>TEST CONDITIONS AND RESULTS.....</u>	<u>8</u>
4.1.	Output Power	8
4.2.	Peak-to-Average Ratio (PAR)	12
4.3.	Occupied Bandwidth and Emission Bandwidth	13
4.4.	Band Edge compliance	16
4.5.	Spurious Emssion on Antenna Port	19
4.6.	Radiated Spurious Emssion	26
4.7.	Frequency Stability under Temperature & Voltage Variations	29
<u>5.</u>	<u>TEST SETUP PHOTOS OF THE EUT</u>	<u>31</u>
<u>6.</u>	<u>EXTERNAL AND INTERNAL PHOTOS OF THE EUT</u>	<u>31</u>

1. TEST STANDARDS

The tests were performed according to following standards:

[FCC Part 27\(10-1-12 Edition\)](#): MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

[ANSI/TIA-603-E-2016](#): Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.

[FCC Part 2](#): FREQUENCY ALLOCA-TIONS AND RADIO TREATY MAT-TERS; GENERAL RULES AND REG-ULATIONS

[ANSI C63.26-2015](#): IEEE/ANSI Standard for Compliance Testing of Transmitters Used in Licensed Radio Services

[FCC KDB971168D01](#) Power Meas License Digital Systems

2. SUMMARY

2.1. General Remarks

Date of receipt of test sample	:	Sep.20, 2019
Testing commenced on	:	Sep.20, 2019
Testing concluded on	:	Oct.25, 2019

2.2. Equipment under Test**Power supply system utilised**

Power supply voltage	:	☐ 120V / 60 Hz	☐ 115V / 60Hz
		☐ 12 V DC	☐ 24 V DC
		☒ Other (specified in blank below)	

DC 3.80V**2.3. Short description of the Equipment under Test (EUT)**

This is a Smart Phone .

For more details, refer to the user's manual of the EUT.

2.4. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

☒ - supplied by the manufacturer

☐ - supplied by the lab

☐ /	M/N : /
	Manufacturer: /

2.5. Related Submittal(s) / Grant (s)

This submittal(s) (test report) is intended for **FCC ID: 2AURV-DIGICELDL3** filing to comply with FCC Part 27, Rules.

2.6. Modifications

No modifications were implemented to meet testing criteria.

2.7. Test Environment

EnvironmentParameter	SelectedValuesDuringTests	
Relative Humidity	Ambient	
Temperature	TN	Ambient
Voltage	VL	3.40V
	VN	3.80V
	VH	4.20V

NOTE:VL=lowerextreme testvoltageVN=nominalvoltage
VH=upperextreme testvoltageTN=normaltemperature

3. TEST ENVIRONMENT

3.1. Address of the test laboratory

Shenzhen Global Test Service Co.,Ltd.

Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055, P. R. China
The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 (2003) and CISPR Publication 22.

3.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 406086

Shenzhen Global Test Service Co.,Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 406086, valid time is until October 28, 2017.

3.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15-35 ° C
Humidity:	30-60 %
Atmospheric pressure:	950-1050mbar

3.4. Test Description

3.4.1 AWS Band (1710-1755MHz paired with 2110-2155MHz)

Test Item	FCC Rule No.	Requirements	Verdict
Effective (Isotropic) Radiated Output Power	§2.1046, §27.50(d)	EIRP ≤ 1W;	Pass
Peak-Average Ratio	§2.1046, §27.50(d)	Limits ≤ 13dB	Pass
Modulation Characteristics	§2.1047	Digital modulation	N/A
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Pass
Band Edges Compliance	§2.1051, §27.53(h)	≤ -13dBm/1%*EBW, in 1MHz bands immediately outside and adjacent to the frequency block.	Pass
Spurious Emission at Antenna Terminals	§2.1051, §27.53(h)	≤ -13dBm/1MHz, from 9kHz to 10 th harmonics but outside authorized operating frequency ranges.	Pass
Field Strength of Spurious Radiation	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Pass
Frequency Stability	§2.1053, §27.53(h)	≤ -13dBm/1MHz.	Pass

NOTE 1: For the verdict, the "N/A" denotes "not applicable", the "N/T" denotes "not tested".

3.5. Equipments Used during the Test

Test Equipment	Manufacturer	Model No.	Serial No.	Calibration Date	Calibration Due Date
LISN	R&S	ENV216	3560.6550.08	2019/09/20	2020/09/19
LISN	R&S	ESH2-Z5	893606/008	2019/09/20	2020/09/19
Bilog Antenna	Schwarzbeck	VULB9163	976	2019/09/20	2020/09/19
Bilog Antenna	Schwarzbeck	VULB9163	979	2019/09/20	2020/09/19
EMI Test Receiver	R&S	ESCI7	101102	2019/09/20	2020/09/19
Spectrum Analyzer	Agilent	N9020A	MY48010425	2019/09/20	2020/09/19
Spectrum Analyzer	R&S	FSP40	100019	2019/09/20	2020/09/19
Controller	EM Electronics	Controller EM 1000	N/A	N/A	N/A
Horn Antenna	Schwarzbeck	BBHA 9120D	01622	2019/09/20	2020/09/19
Horn Antenna	Schwarzbeck	BBHA 9120D	01652	2019/09/20	2020/09/19
Active Loop Antenna	SCHWARZBEC K	FMZB1519	1519-037	2019/09/20	2020/09/19
Broadband Horn Antenna	SCHWARZBEC K	BBHA 9170	971	2019/09/20	2020/09/19
Amplifier	Schwarzbeck	BBV 9743	#202	2019/09/20	2020/09/19
Amplifier	EMCI	EMC051845B	980355	2019/09/20	2020/09/19
Temperature/Humidity Meter	Gangxing	CTH-608	02	2019/09/20	2020/09/19
High-Pass Filter	K&L	9SH10-2700/X12750-O/O	KL142031	2019/09/20	2020/09/19
High-Pass Filter	K&L	41H10-1375/U12750-O/O	KL142032	2019/09/20	2020/09/19
RF Cable(below 1GHz)	HUBER+SUHNER	RG214	RE01	2019/09/20	2020/09/19
RF Cable(above 1GHz)	HUBER+SUHNER	RG214	RE02	2019/09/20	2020/09/19
Data acquisition card	Agilent	U2531A	TW53323507	2019/09/20	2020/09/19
Power Sensor	Agilent	U2021XA	MY5365004	2019/09/20	2020/09/19
EMI Test Software	R&S	ES-K1	V1.7.1	2019/09/20	2020/09/19
EMI Test Software	JS Tonscend	JS32-RE	2.0.1.5	2019/09/20	2020/09/19
EMI Test Software	Audix	E3	2..1.1	2019/09/20	2020/09/19

The calibration interval was one year.

4. TEST CONDITIONS AND RESULTS

4.1. Output Power

LIMIT

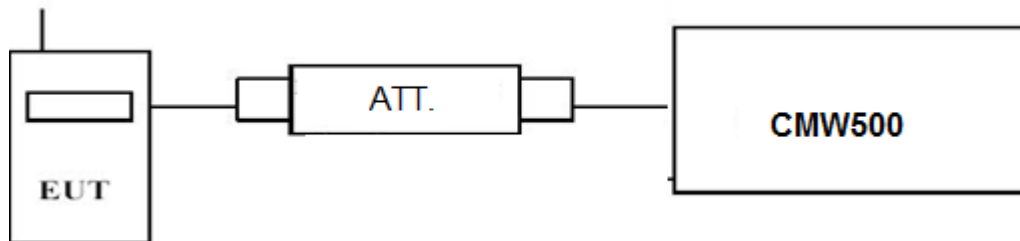
According to §27.50 (d) (4): Fixed, mobile, and portable (hand- held) stations operating in the 704–716 MHz band are limited to 1 watt EIRP

TEST APPLICABLE

During the process of testing, the EUT was controlled via R&S Digital Radio Communication tester (CMW500) to ensure max power transmission and proper modulation. This result contains output power and EIRP measurements for the EUT. In all cases, output power is within the specified limits

4.1.1. Conducted Output Power

TEST CONFIGURATION



TEST PROCEDURE

Conducted Power Measurement:

- Place the EUT on a bench and set it in transmitting mode.
- Connect a low loss RF cable from the antenna port to a CMW500 by an Att.
- EUT Communicate with CMW500 then selects a channel for testing.
- Add a correction factor to the display CMW500, and then test.

TEST RESULTS

Remark:

- We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17;

LTE FDD Band 17				
TX Channel Bandwidth	Frequency (MHz)	RB Size/Offset	Average Power [dBm]	
			QPSK	16QAM
5 MHz	706.5	1 RB low	23.37	22.41
		1 RB Mid	23.17	22.28
		1 RB high	23.38	22.49
		50% RB Low	22.62	21.69
		50% RB mid	22.55	21.62
		50% RB high	22.52	21.50
		100% RB	22.15	21.31
	710	1 RB low	23.16	22.21
		1 RB Mid	23.42	22.47
		1 RB high	23.27	22.22
		50% RB Low	22.54	21.63
		50% RB mid	22.59	21.68
		50% RB high	22.38	21.35
		100% RB	22.03	21.16
	713.5	1 RB low	23.24	22.39
		1 RB Mid	23.13	22.30

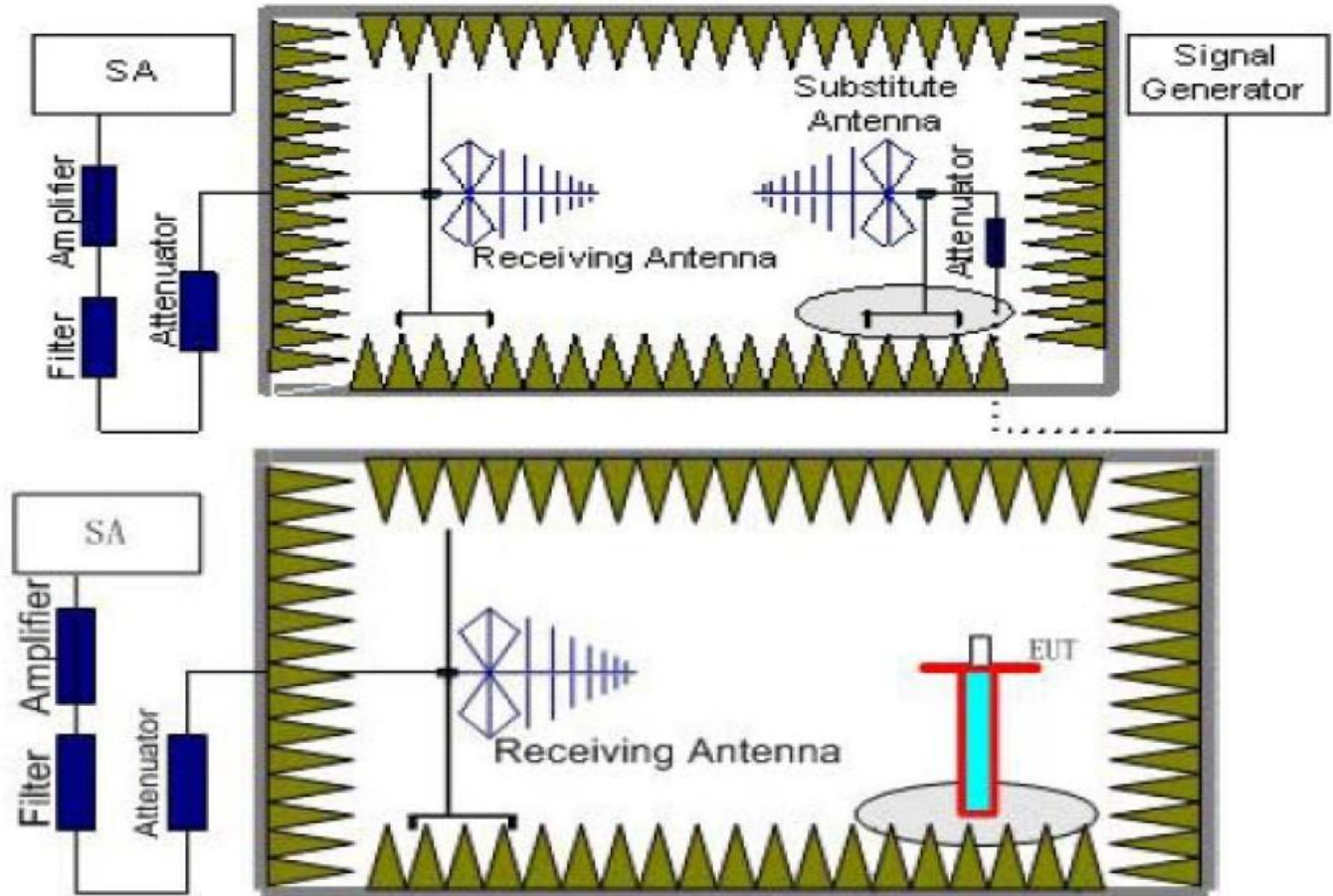
10 MHz		1 RB high	23.31	22.39
		50% RB Low	22.36	21.41
		50% RB mid	22.57	21.65
		50% RB high	22.27	21.34
		100% RB	22.06	21.16
	709	1 RB low	23.49	22.58
		1 RB Mid	23.35	22.36
		1 RB high	23.63	22.69
		50% RB Low	22.74	21.80
		50% RB mid	22.65	21.73
		50% RB high	22.76	21.86
		100% RB	22.17	21.21
	710	1 RB low	23.49	22.57
		1 RB Mid	23.54	21.91
		1 RB high	23.59	22.52
		50% RB Low	22.87	21.97
		50% RB mid	22.79	21.90
		50% RB high	22.81	21.79
		100% RB	22.33	21.49
	711	1 RB low	23.49	22.59
		1 RB Mid	23.13	22.28
		1 RB high	23.52	22.62
		50% RB Low	22.56	21.53
		50% RB mid	22.75	21.84
		50% RB high	22.51	21.49
		100% RB	22.16	21.41

4.1.2. Radiated Output Power

LIMIT

According to §27.50 (d) (4): Fixed, mobile, and portable (hand- held) stations operating in the 704–716 MHz band are limited to 1 watt EIRP.

TEST CONFIGURATION



TEST PROCEDURE

1. EUT was placed on a 0.80 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the EUT for emission measurements. The height of receiving antenna is 0.80m. Detected emissions were maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna polarization. The radiated emission measurements of all transmit frequencies in three channels (High, Middle, Low) were measured with peak detector.
2. A log-periodic antenna or double-ridged waveguide horn antenna shall be substituted in place of the EUT. The log-periodic antenna will be driven by a signal generator and the level will be adjusted till the same power value on the spectrum analyzer or receiver. The level of the spurious emissions can be calculated through the level of the signal generator, cable loss, the gain of the substitution antenna and the reading of the spectrum analyzer or receiver.
3. The EUT is then put into continuously transmitting mode at its maximum power level during the test. Set Test Receiver or Spectrum RBW=1MHz, VBW=3MHz, And the maximum value of the receiver should be recorded as (P_r).
4. The EUT shall be replaced by a substitution antenna. In the chamber, an substitution antenna for the frequency band of interest is placed at the reference point of the chamber. An RF Signal source for the frequency band of interest is connected to the substitution antenna with a cable that has been constructed to not interfere with the radiation pattern of the antenna. A power (P_{Mea}) is applied to the input of the substitution antenna, and adjust the level of the signal generator output until the value of the receiver reach the previously recorded (P_r). The power of signal source (P_{Mea}) is recorded. The test should be performed by rotating the test item and adjusting the receiving antenna polarization.

5. A amplifier should be connected to the Signal Source output port. And the cable should be connect between the Amplifier and the Substitution Antenna. The cable loss (P_{cl}) ,the Substitution Antenna Gain (G_a) and the Amplifier Gain (P_{Ag}) should be recorded after test.

The measurement results are obtained as described below:

$$\text{Power(EIRP)} = P_{\text{Mea}} - P_{\text{Ag}} - P_{\text{cl}} + G_a$$

We used SMF100A microwave signal generator which signal level can up to 33dBm,so we not used power Amplifier for substitution test; The measurement results are amend as described below:

$$\text{Power(EIRP)} = P_{\text{Mea}} - P_{\text{cl}} + G_a$$

6. This value is EIRP since the measurement is calibrated using an antenna of known gain (2.15 dBi) and known input power.
7. ERP can be calculated from EIRP by subtracting the gain of the dipole, $\text{ERP} = \text{EIRP} - 2.15\text{dBi}$.

TEST RESULTS

Note: We test the H direction and V direction and V direction is worse.

Remark:

2. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17 recorded worst case for each Channel Bandwidth of LTE FDD Band 17
3. $\text{EIRP} = P_{\text{Mea}}(\text{dBm}) - P_{\text{cl}}(\text{dB}) + P_{\text{Ag}}(\text{dB}) + G_a(\text{dBi})$

LTE FDD Band 17 Channel Bandwidth 5MHz_QPSK

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	ERP (dBm)	Limit (dBm)	Margin (dB)	Polarization
706.5	-19.91	2.42	8.24	33.54	19.45	30	10.55	H
710	-18.73	2.42	8.24	33.54	20.63	30	9.37	H
713.5	-19.41	2.42	8.24	33.54	19.95	30	10.05	H

LTE FDD Band 17 Channel Bandwidth 10MHz_QPSK

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	ERP (dBm)	Limit (dBm)	Margin (dB)	Polarization
709	-20.10	2.42	8.24	33.54	19.26	30	10.74	H
710	-18.78	2.42	8.24	33.54	20.58	30	9.42	H
711	-19.70	2.42	8.24	33.54	19.66	30	10.34	H

LTE FDD Band 17 Channel Bandwidth 5MHz_16QAM

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	ERP (dBm)	Limit (dBm)	Margin (dB)	Polarization
706.5	-20.07	2.42	8.24	33.54	19.29	30	10.71	H
710	-19.24	2.42	8.24	33.54	20.12	30	9.88	H
713.5	-19.95	2.42	8.24	33.54	19.41	30	10.59	H

LTE FDD Band 17 Channel Bandwidth 10MHz_16QAM

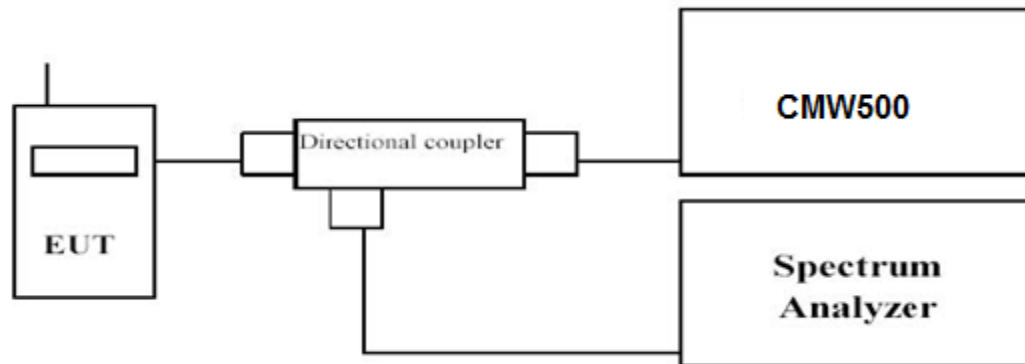
Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	G_a Antenna Gain(dB)	P_{Ag} (dB)	ERP (dBm)	Limit (dBm)	Margin (dB)	Polarization
709	-20.03	2.42	8.24	33.54	19.33	30	10.67	H
710	-19.70	2.42	8.24	33.54	19.66	30	10.34	H
711	-20.09	2.42	8.24	33.54	19.27	30	10.73	H

4.2. Peak-to-Average Ratio (PAR)

LIMIT

The Peak-to-Average Ratio (PAR) of the transmission may not exceed 13 dB.

TEST CONFIGURATION



TEST PROCEDURE

1. Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
2. Set resolution/measurement bandwidth $\geq$ signal's occupied bandwidth;
3. Set the number of counts to a value that stabilizes the measured CCDF curve;
4. Set the measurement interval as follows:
 - 1). for continuous transmissions, set to 1 ms,
 - 2). for burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.
5. Record the maximum PAPR level associated with a probability of 0.1%.

TEST RESULTS

Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17; recorded worst case for each Channel Bandwidth of LTE FDD Band 17.

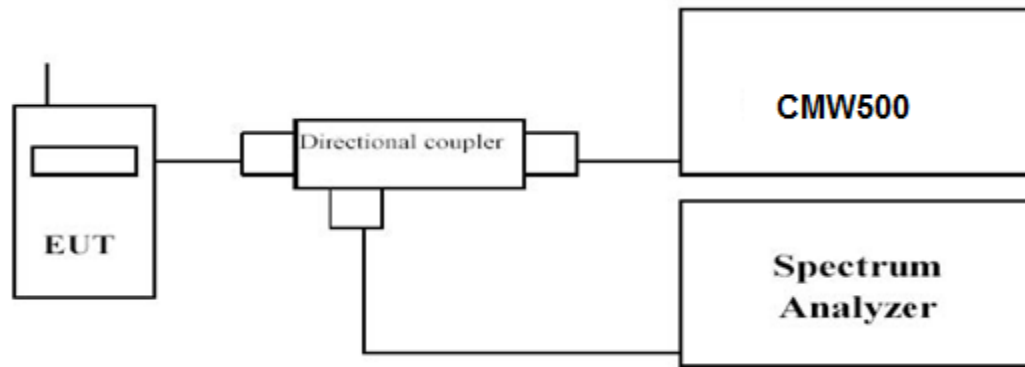
LTE FDD Band 17				
TX Channel Bandwidth	Frequency (MHz)	RB Size/Offset	PAPR (dB)	
			QPSK	16QAM
5 MHz	706.5	1RB#0	2.85	2.72
	710		2.76	2.83
	713.5		2.79	2.79
10 MHz	709	1RB#0	3.85	3.96
	710		3.92	3.85
	711		3.69	3.97

4.3. Occupied Bandwidth and Emission Bandwidth

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at low, middle and high channel in each band. The -26dBc Emission bandwidth was also measured and recorded.

Set RBW was set to about 1% of emission BW, VBW $\geq$ 3 times RBW.

-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

TEST RESULTS

Remark:

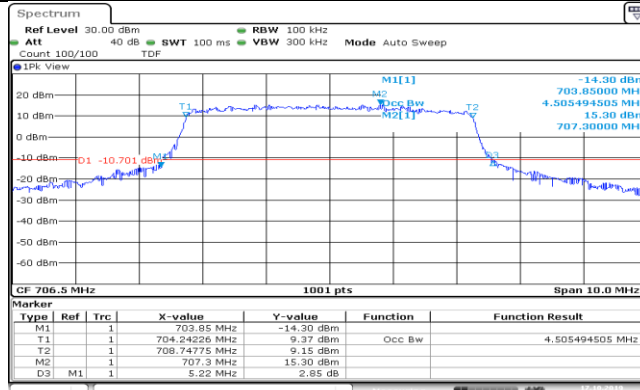
1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17; recorded worst case for each Channel Bandwidth of LTE FDD Band 17.

LTE FDD Band 17						
TX Channel Bandwidth	RB Size/Offset	Frequency (MHz)	-26dBc Emission bandwidth (MHz)		99% Occupied bandwidth (MHz)	
			QPSK	16QAM	QPSK	16QAM
5 MHz	25RB#0	706.5	5.220	5.160	4.506	4.486
		710	5.550	5.670	4.546	4.575
		713.5	5.230	5.540	4.516	4.545
10 MHz	50RB#0	709	10.267	10.400	9.052	9.018
		710	10.233	10.267	9.052	9.085
		711	10.267	10.267	9.052	9.052

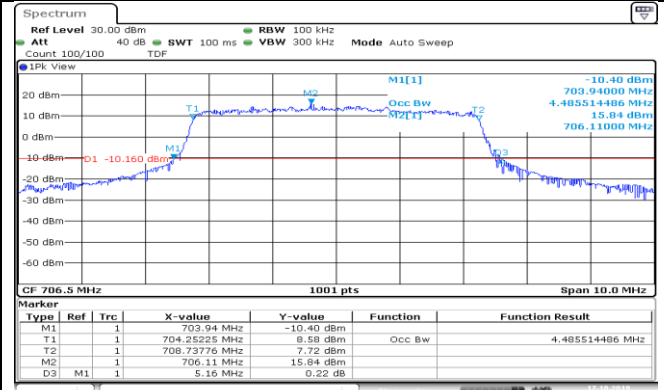
LTE FDD Band 7-5MHz Channel Bandwidth

QPSK

16QAM



Date: 17.OCT.2019 11:46:43

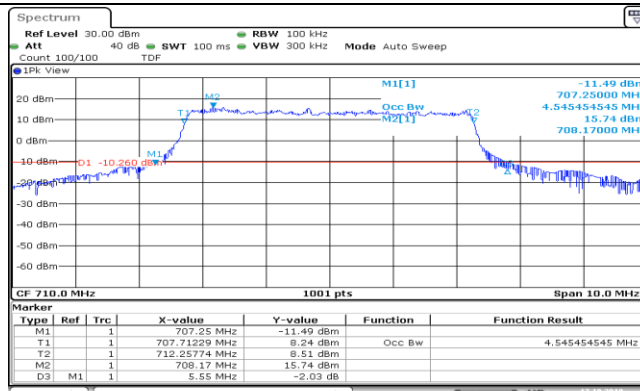


Date: 17.OCT.2019 11:47:01

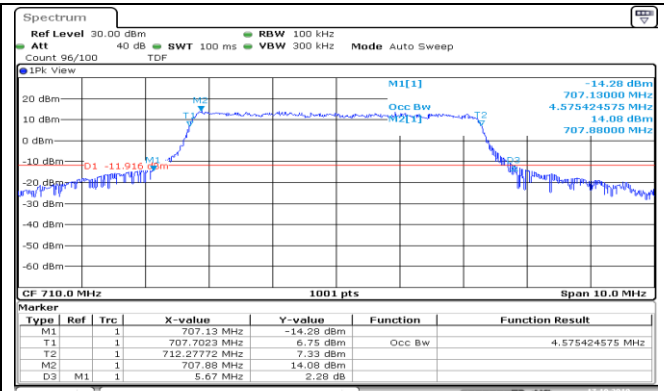
25RB#0

25RB#0

Low Channel



Date: 17.OCT.2019 11:47:20

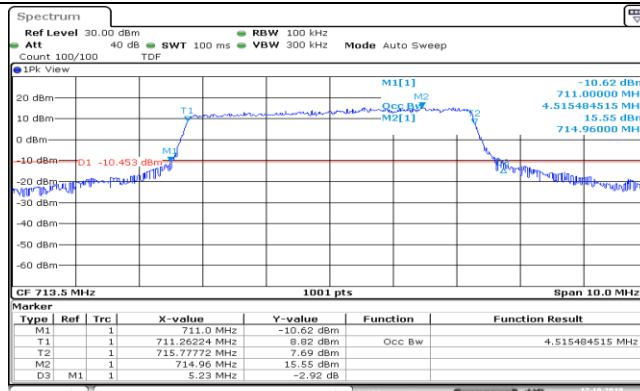


Date: 17.OCT.2019 11:47:38

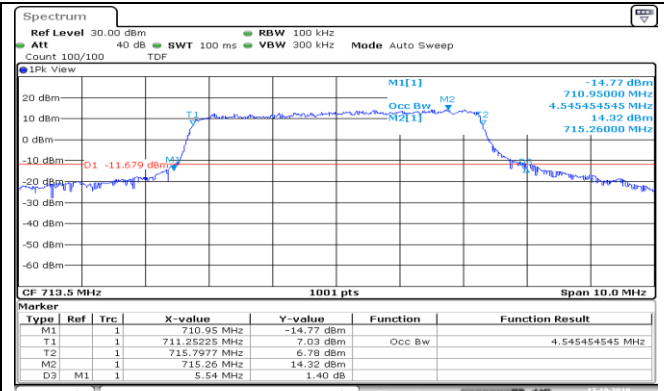
25RB#0

25RB#0

Middle Channel



Date: 17.OCT.2019 11:47:57



Date: 17.OCT.2019 11:48:15

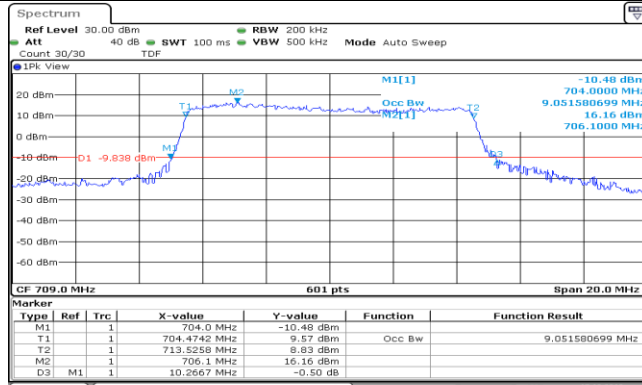
25RB#0

25RB#0

High Channel

LTE FDD Band 7-10MHz Channel Bandwidth

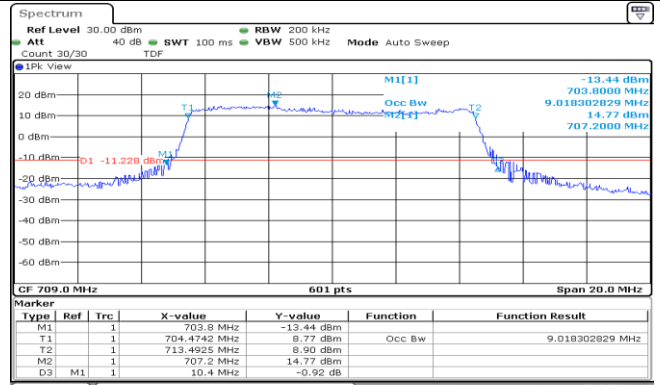
QPSK



Date: 17.OCT.2019 11:54:55

50RB#0

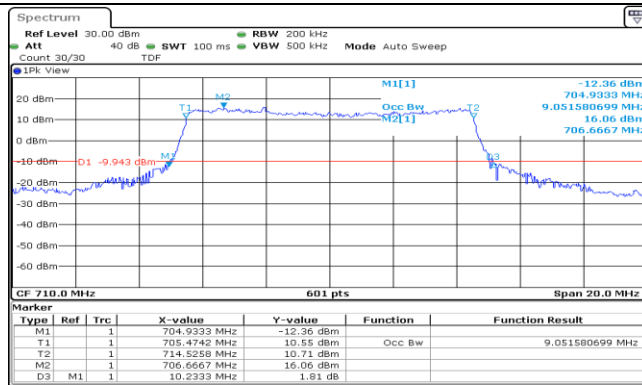
16QAM



Date: 17.OCT.2019 11:55:06

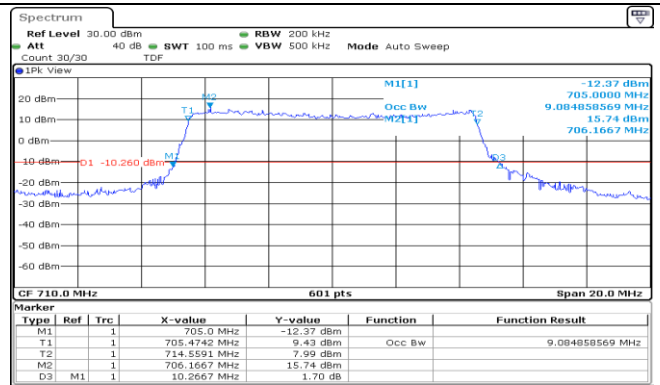
50RB#0

Low Channel



Date: 17.OCT.2019 11:55:18

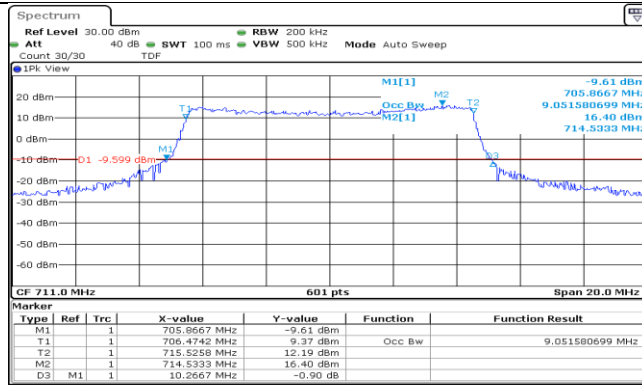
50RB#0



Date: 17.OCT.2019 11:55:29

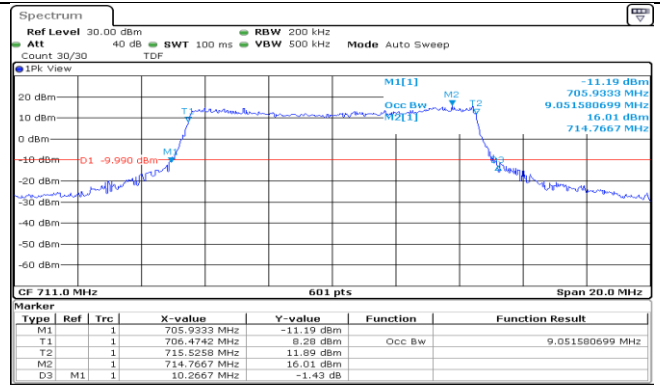
50RB#0

Middle Channel



Date: 17.OCT.2019 11:55:41

50RB#0



Date: 17.OCT.2019 11:55:52

50RB#0

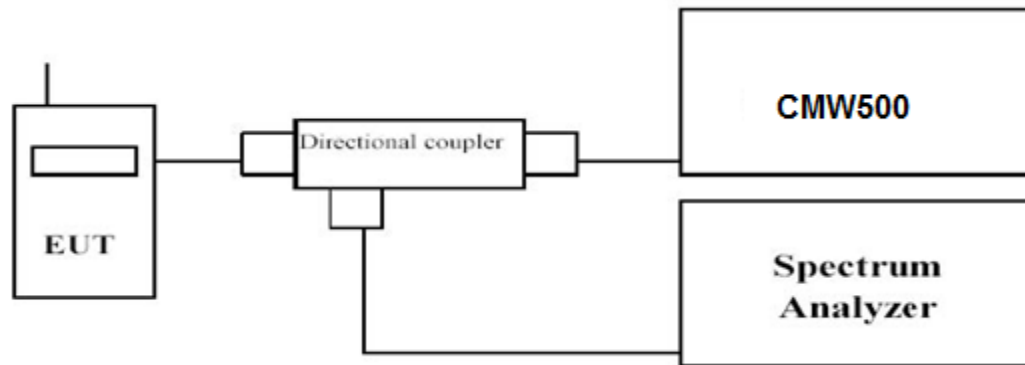
High Channel

4.4. Band Edge compliance

LIMIT

According to §27.53 (h): For operations in the 704–716 MHz, the power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) by at least $43 + 10 \log_{10}(P)$ dB.

TEST CONFIGURATION



TEST PROCEDURE

1. The transmitter output port was connected to base station.
2. The RF output of EUT was connected to the power meter by RF cable and attenuator, the path loss was compensated to the results for each measurement.
3. Set EUT at maximum power through base station.
4. Select lowest and highest channels for each band and different modulation.
5. Measure Band edge using RMS (Average) detector by spectrum

TEST RESULTS

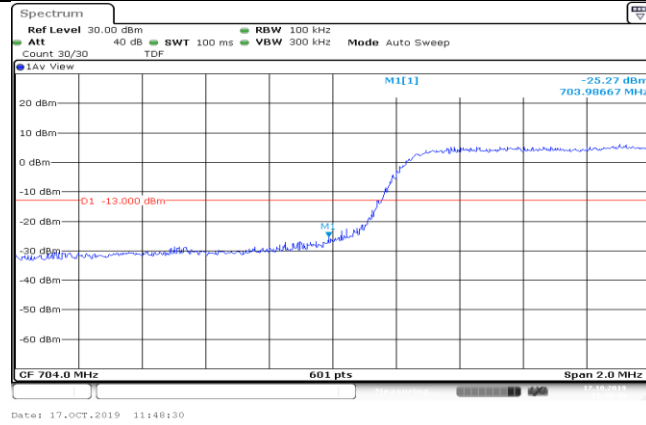
Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17; recorded worst case for each Channel Bandwidth of LTE FDD Band 17.

LTE FDD Band 17-5MHz Channel Bandwidth Band Edge Compliance

QPSK

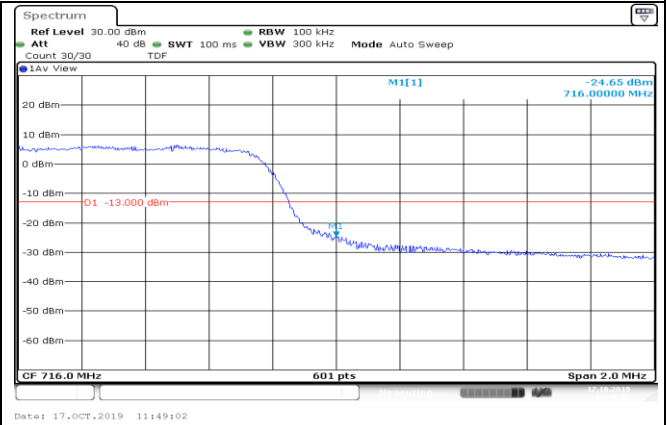
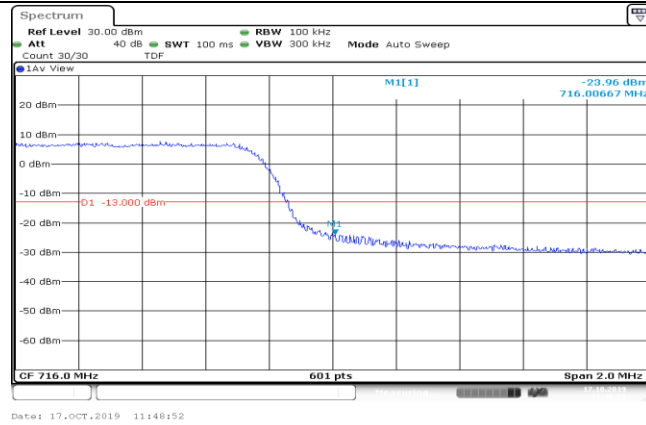
16QAM



25 RB#0

25 RB#0

Low Channel



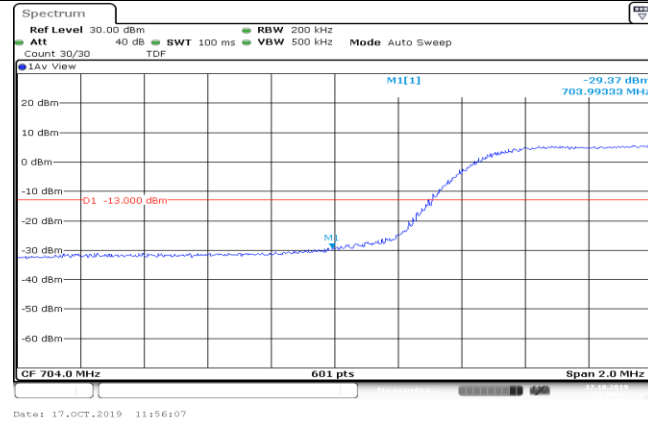
25 RB#0

25 RB#0

High Channel

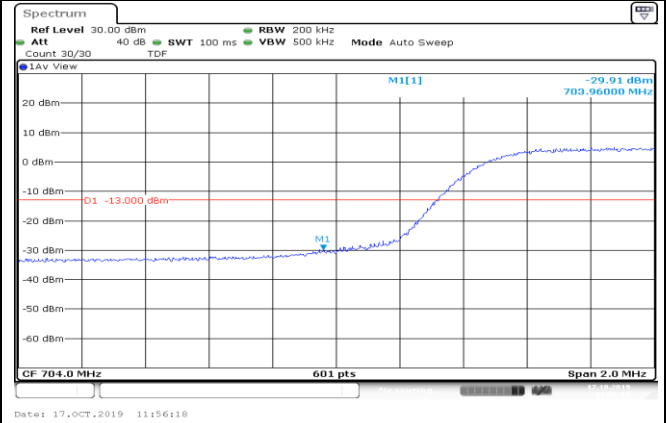
LTE FDD Band 17-10MHz Channel Bandwidth Band Edge Compliance

QPSK



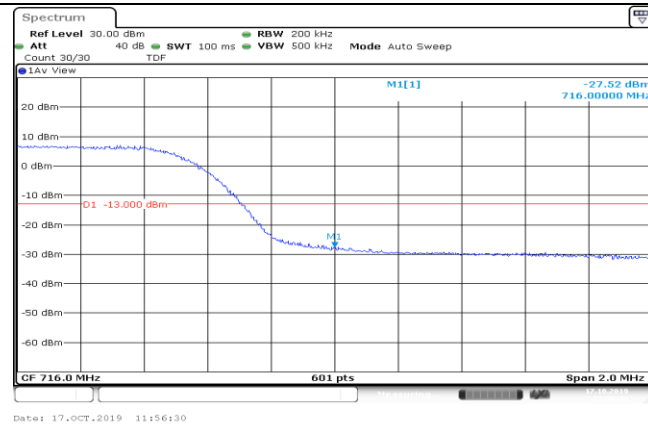
50 RB#0

16QAM

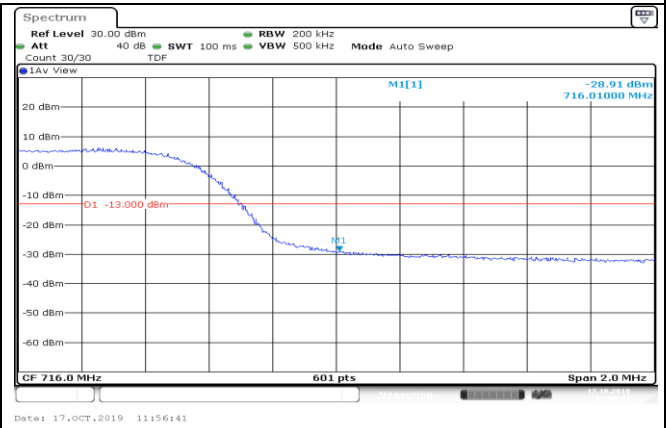


50 RB#0

Low Channel



50 RB#0



50 RB#0

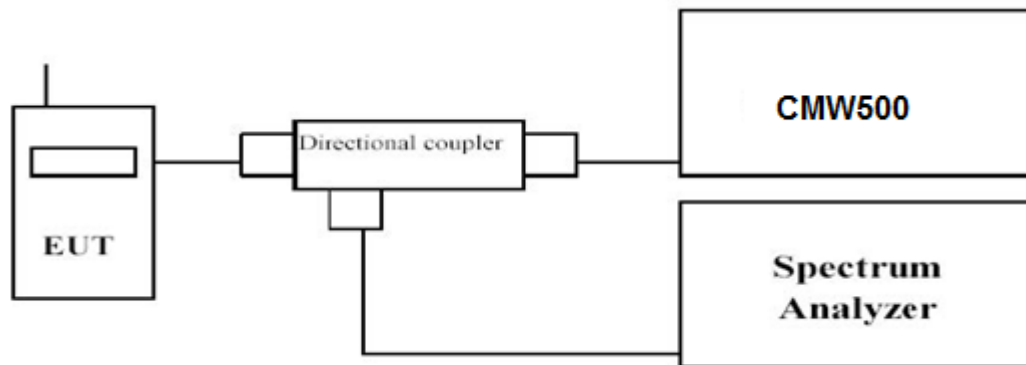
High Channel

4.5. Spurious Emission on Antenna Port

LIMIT

According to §27.53 (h): For operations in the 704–716 MHz bands, the power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) by at least $43 + 10 \log_{10}(P)$ dB.

TEST CONFIGURATION



TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

- Place the EUT on a bench and set it in transmitting mode.
- Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
- EUT Communicate with CMW500, then select a channel for testing.
- Add a correction factor to the display of spectrum, and then test.
- The resolution bandwidth of the spectrum analyzer was set sufficient scans were taken to show the out of band Emission if any up to 10th harmonic.
- Please refer to following tables for test antenna conducted emissions

Working Frequency	Sub range (GHz)	RBW	VBW	Sweep time (s)
LTE FDD Band 17	0.000009~0.000015	1KHz	3KHz	Auto
	0.000015~0.03	10KHz	30KHz	Auto
	0.03~26.5	1 MHz	3 MHz	Auto

TEST RESULTS

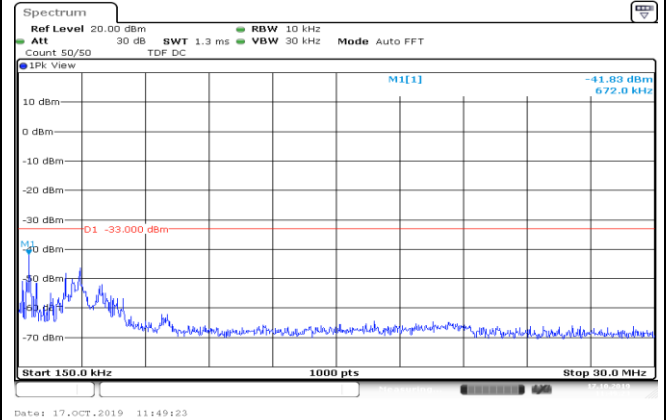
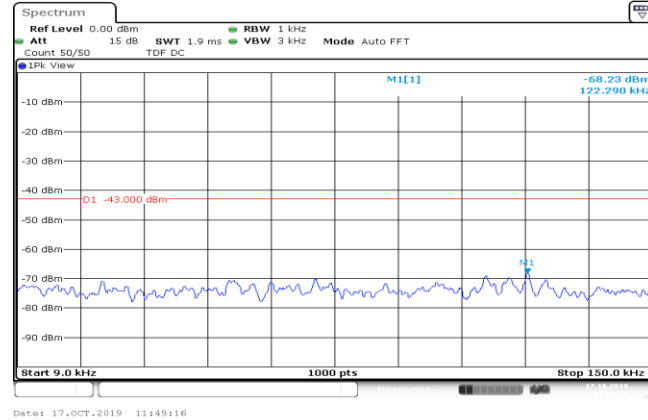
Remark:

- We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17; recorded worst case for each Channel Bandwidth of LTE FDD Band 17.

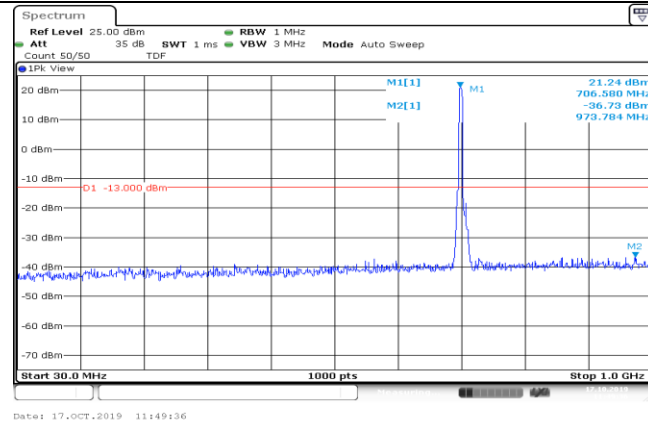
LTE FDD Band 17-5MHz Channel Bandwidth

Low Channel

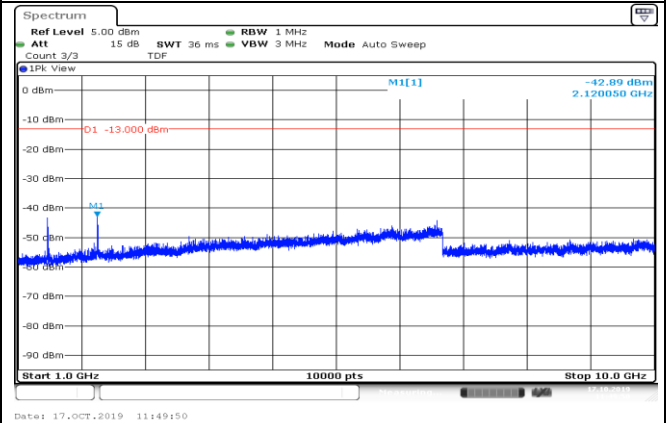
QPSK



9KHz~150KHz



150KHz~30MHz



30MHz~1GHz

1RB#0

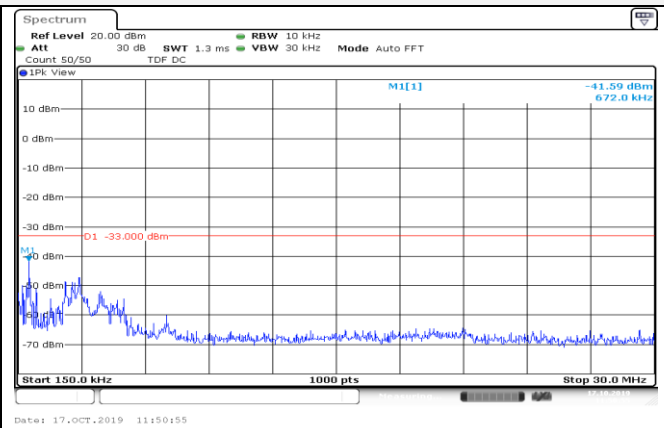
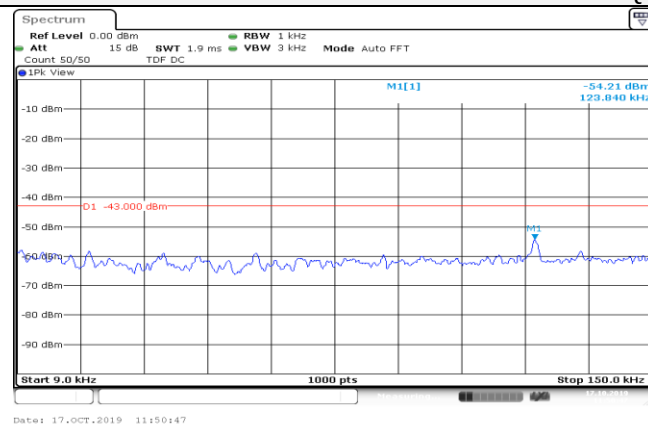
1GHz ~10GHz

1RB#0

LTE FDD Band 17-5MHz Channel Bandwidth

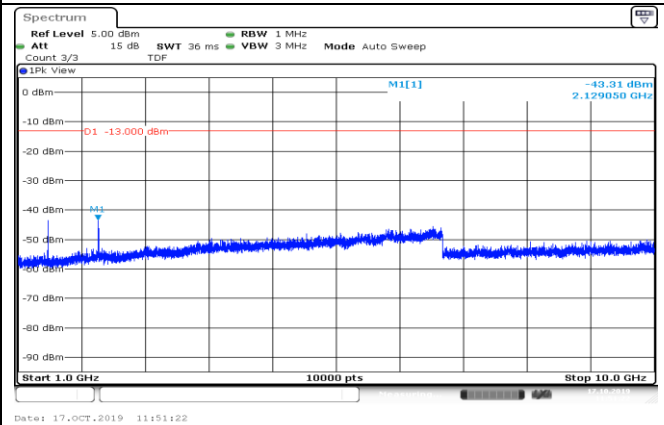
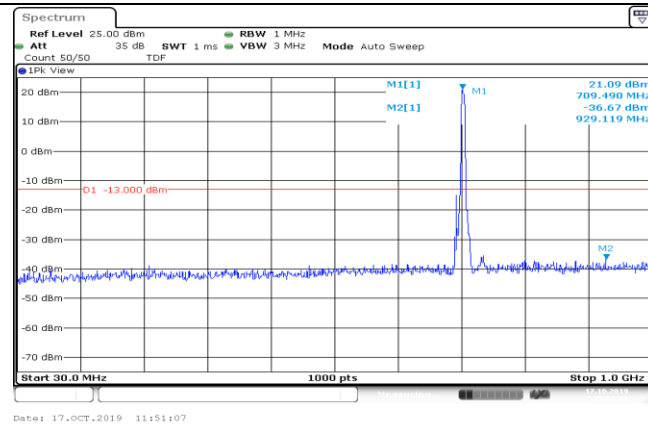
Middle Channel

QPSK



9KHz~150KHz

150KHz~30MHz



30MHz~1GHz

1GHz ~10GHz

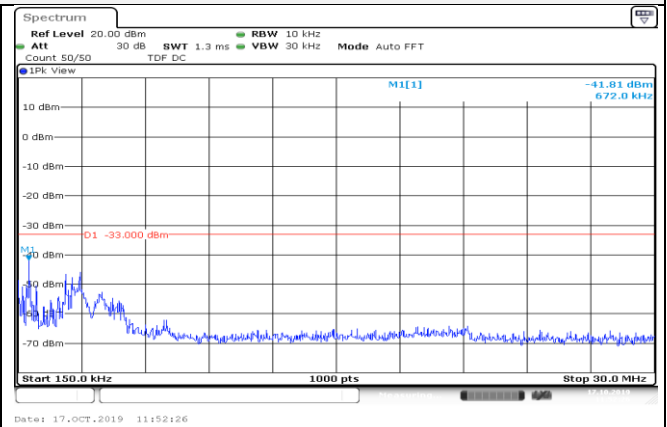
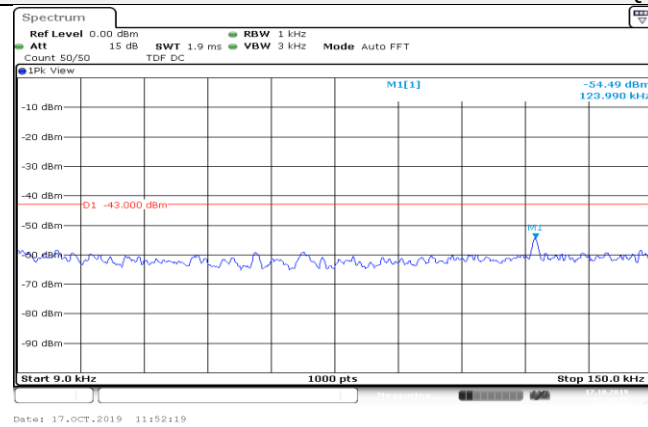
QPSK

1RB#0

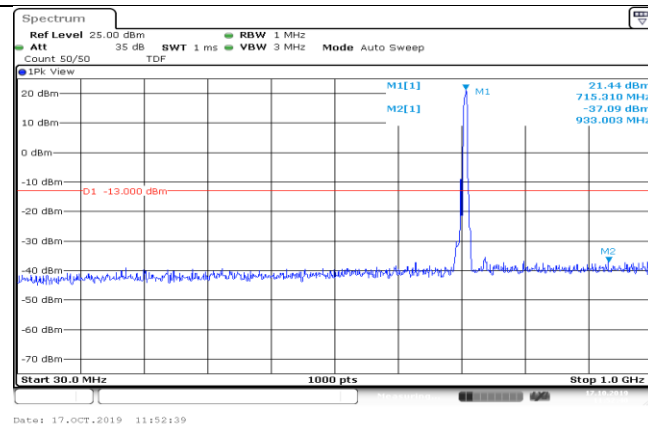
LTE FDD Band 17-5MHz Channel Bandwidth

High Channel

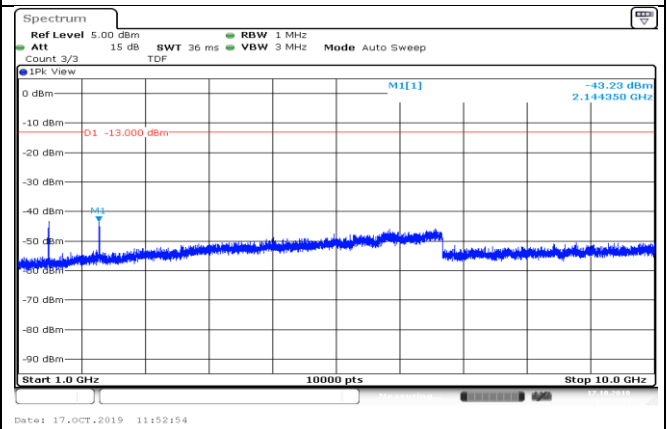
QPSK



9KHz~150KHz



150KHz~30MHz



30MHz~1GHz

1RB#0

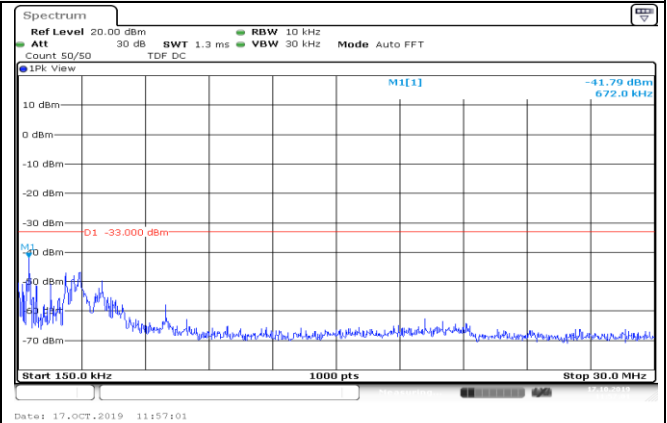
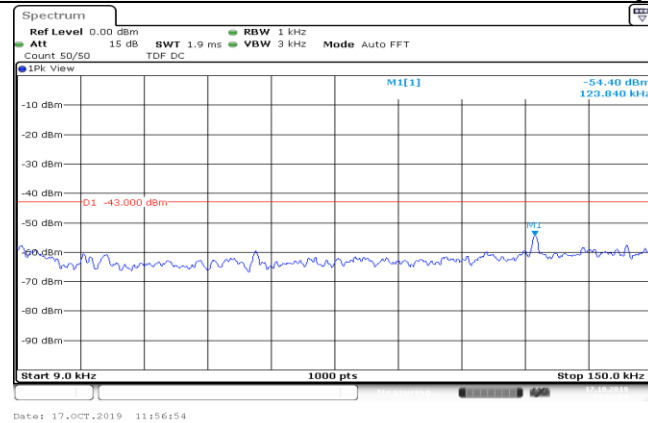
1GHz~10GHz

1RB#0

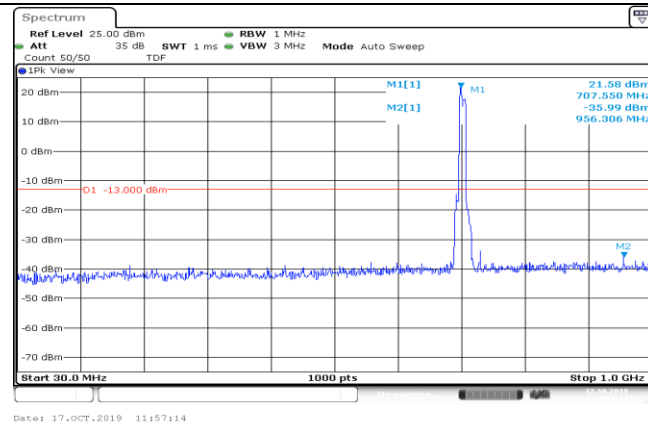
LTE FDD Band 17-10 MHz Channel Bandwidth

Low Channel

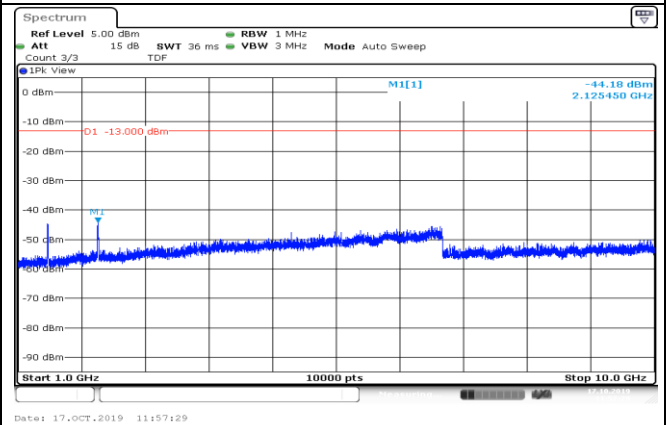
QPSK



9KHz~150KHz



150KHz~30MHz



30MHz~1GHz

1RB#0

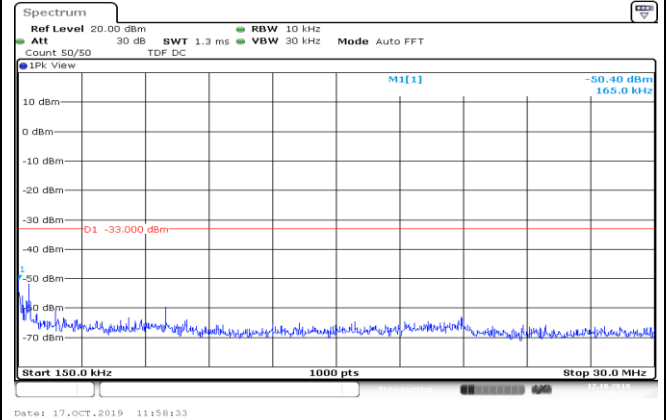
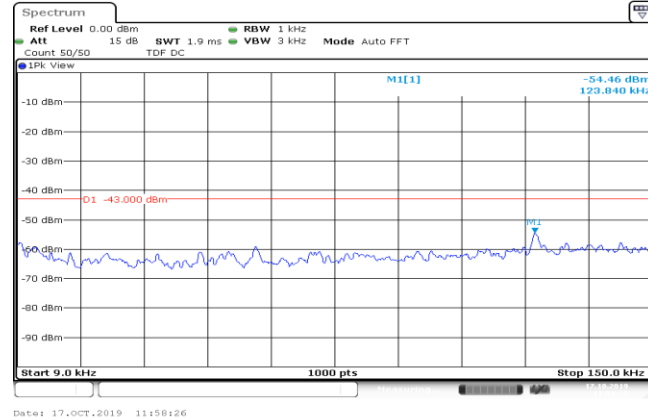
1GHz ~10GHz

1RB#0

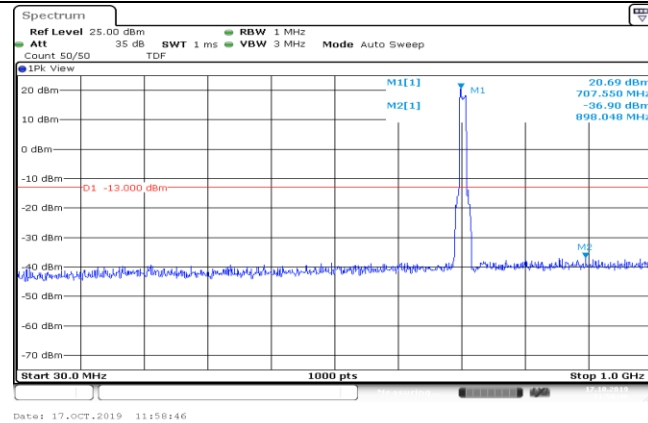
LTE FDD Band 17-10 MHz Channel Bandwidth

Middle Channel

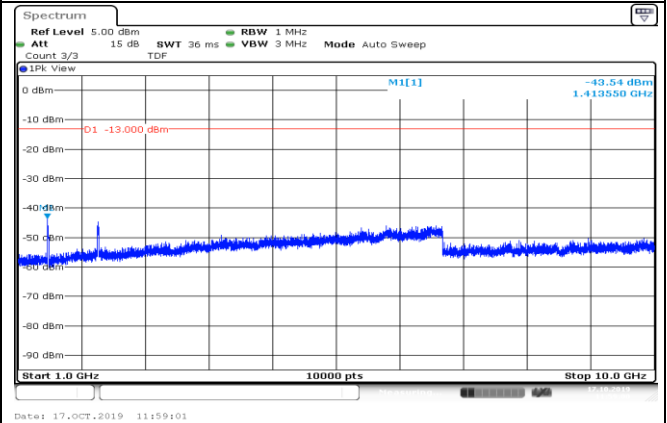
QPSK



9KHz~150KHz



150KHz~30MHz



30MHz~1GHz

1RB#0

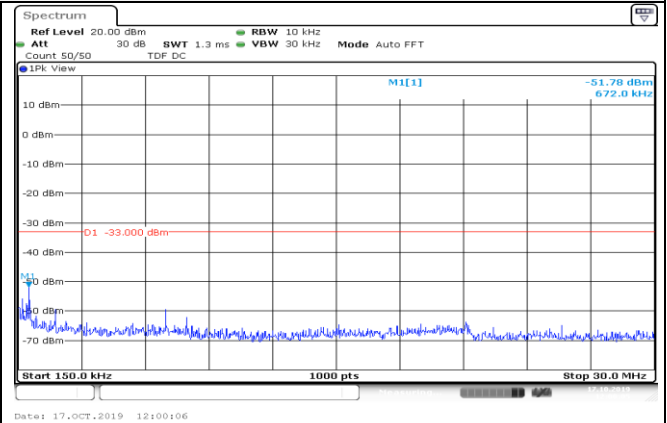
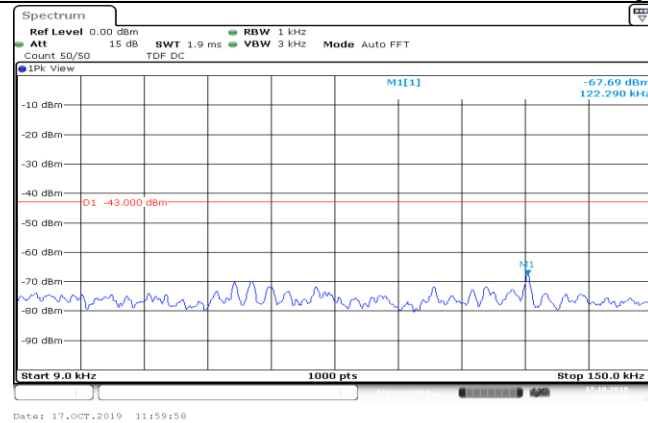
1GHz ~10GHz

1RB#0

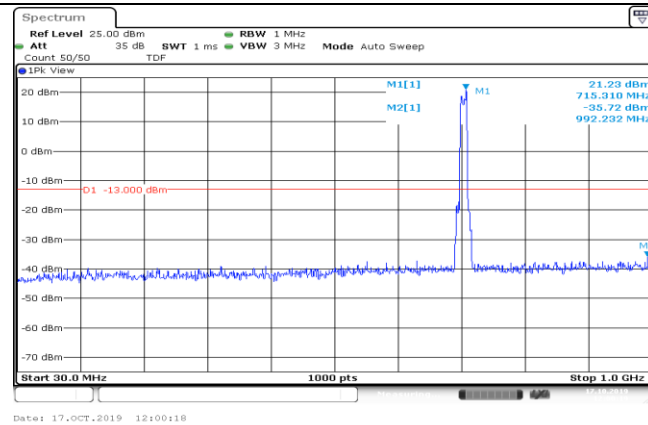
LTE FDD Band 17-10 MHz Channel Bandwidth

High Channel

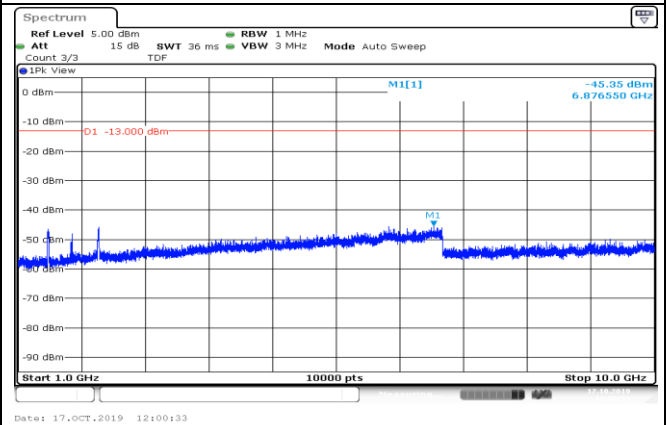
QPSK



9KHz~150KHz



150KHz~30MHz



30MHz~1GHz

1RB#0

1GHz ~10GHz

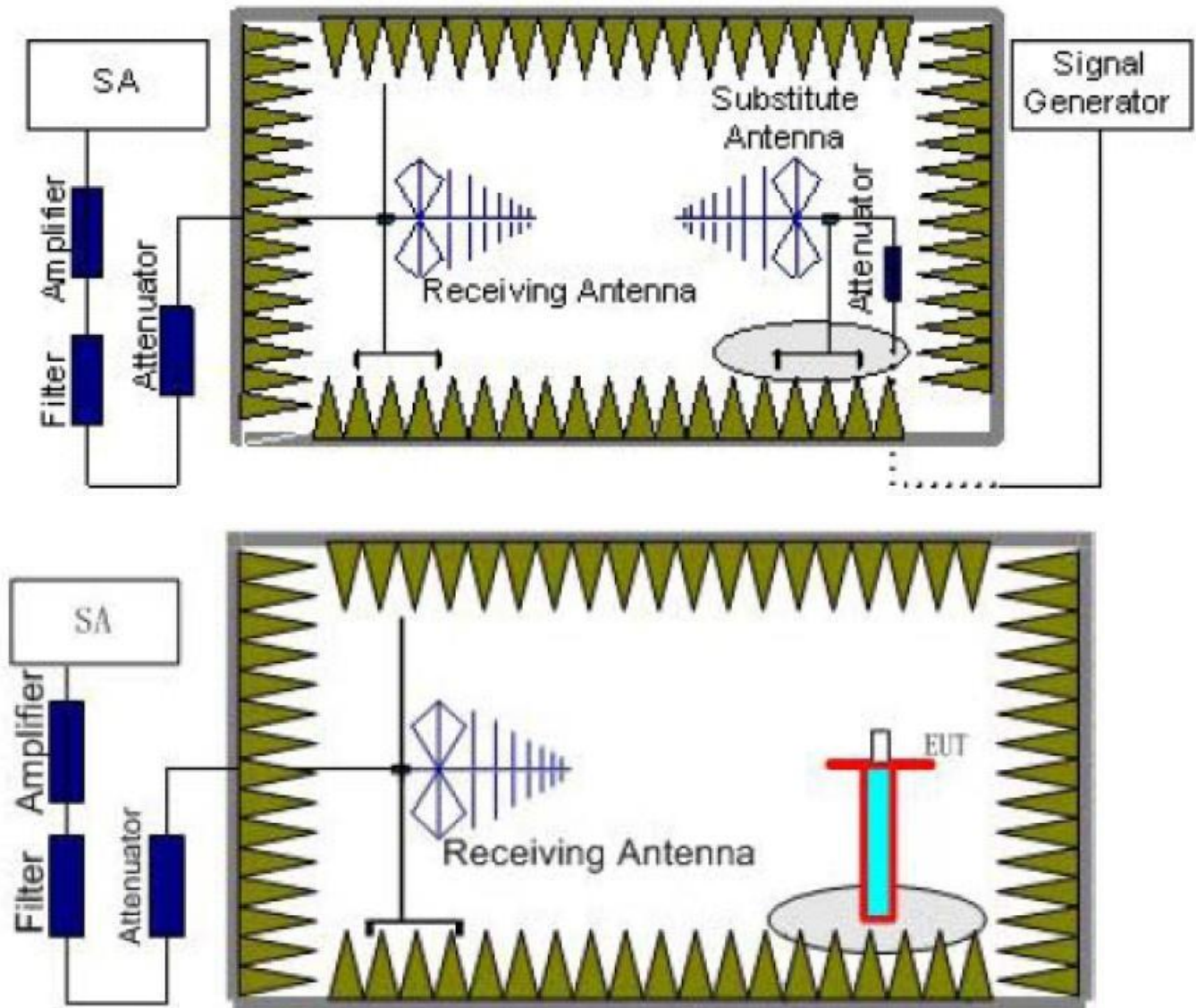
1RB#0

4.6. Radiated Spurious Emission

LIMIT

According to §27.53 (h): For operations in the 704–716 MHz bands, the power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) by at least $43 + 10 \log_{10}(P)$ dB.

TEST CONFIGURATION



TEST PROCEDURE

1. EUT was placed on a 0.80 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the EUT for emission measurements. The height of receiving antenna is 0.80m. Detected emissions were maximized at each frequency by rotating the EUT through 360° and adjusting the receiving antenna polarization. The radiated emission measurements of all transmit frequencies in three channels (High, Middle, Low) were measured with peak detector.
2. A log-periodic antenna or double-ridged waveguide horn antenna shall be substituted in place of the EUT. The log-periodic antenna will be driven by a signal generator and the level will be adjusted till the same power value on the spectrum analyzer or receiver. The level of the spurious emissions can be calculated through the level of the signal generator, cable loss, the gain of the substitution antenna and the reading of the spectrum analyzer or receiver.
3. The EUT is then put into continuously transmitting mode at its maximum power level during the test. Set Test Receiver or Spectrum RBW=1MHz, VBW=3MHz, And the maximum value of the receiver should be recorded as (P_r).

4. The EUT shall be replaced by a substitution antenna. In the chamber, an substitution antenna for the frequency band of interest is placed at the reference point of the chamber. An RF Signal source for the frequency band of interest is connected to the substitution antenna with a cable that has been constructed to not interfere with the radiation pattern of the antenna. A power (P_{Mea}) is applied to the input of the substitution antenna, and adjust the level of the signal generator output until the value of the receiver reach the previously recorded (P_r). The power of signal source (P_{Mea}) is recorded. The test should be performed by rotating the test item and adjusting the receiving antenna polarization.
5. A amplifier should be connected to the Signal Source output port. And the cable should be connect between the Amplifier and the Substitution Antenna. The cable loss (P_{cl}), the Substitution Antenna Gain (G_a) and the Amplifier Gain (P_{Ag}) should be recorded after test.
The measurement results are obtained as described below:
 $Power(EIRP) = P_{Mea} - P_{Ag} - P_{cl} + G_a$
6. This value is EIRP since the measurement is calibrated using an antenna of known gain (2.15 dBi) and known input power.
7. ERP can be calculated from EIRP by subtracting the gain of the dipole, $ERP = EIRP - 2.15dBi$.
8. In order to make sure test results more clearly, we set frequency range and sweep time for difference frequency range as follows table:

Working Frequency	Subrange (GHz)	RBW	VBW	Sweep time (s)
LTE FDD Band 17	0.00009~0.15	1KHz	3KHz	30
	0.00015~0.03	10KHz	30KHz	10
	0.03~1	100KHz	300KHz	10
	1~2	1 MHz	3 MHz	2
	2~5	1 MHz	3 MHz	3
	5~8	1 MHz	3 MHz	3

Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17; recorded worst case for each Channel Bandwidth of LTE FDD Band 17.
2. $EIRP = P_{Mea}(dBm) - P_{cl}(dB) + G_a(dBi)$
3. We were not recorded other points as values lower than limits.
4. $Margin = Limit - EIRP$

LTE FDD Band 17_Channel Bandwidth 5MHz_QPSK_Low Channel

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	Diatance	G_a Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1413	-40.47	2.98	3	8.68	-34.77	-13.00	21.77	H
2118.9	-44.87	3.65	3	10.52	-38.00	-13.00	25.00	H
1413	-42.49	2.98	3	8.68	-36.79	-13.00	23.79	V
2118.9	-47.91	3.65	3	10.52	-41.04	-13.00	28.04	V

LTE FDD Band 17_Channel Bandwidth 5MHz_QPSK_Middle Channel

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	Diatance	G_a Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1420	-37.68	2.98	3	8.68	-31.98	-13.00	18.98	H
2130	-42.07	3.65	3	10.52	-35.20	-13.00	22.20	H
1420	-46.23	2.98	3	8.68	-40.53	-13.00	27.53	V
2130	-49.33	3.65	3	10.52	-42.46	-13.00	29.46	V

LTE FDD Band 17_Channel Bandwidth 5MHz_QPSK_High Channel

Frequency (MHz)	P_{Mea} (dBm)	P_{cl} (dB)	Diatance	G_a Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1427	-40.29	2.98	3	8.68	-34.59	-13.00	21.59	H
2140.5	-43.58	3.65	3	10.52	-36.71	-13.00	23.71	H
1427	-42.62	2.98	3	8.68	-36.92	-13.00	23.92	V
2140.5	-48.46	3.65	3	10.52	-41.59	-13.00	28.59	V

LTE FDD Band 17_Channel Bandwidth 10MHz_QPSK_Low Channel

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	Diatance	G _a Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1418	-42.95	2.98	3	8.68	-37.25	-13.00	24.25	H
2127	-46.60	3.65	3	10.52	-39.73	-13.00	26.73	H
1418	-48.06	2.98	3	8.68	-42.36	-13.00	29.36	V
2127	-50.68	3.65	3	10.52	-43.81	-13.00	30.81	V

LTE FDD Band 17_Channel Bandwidth 10MHz_QPSK_Middle Channel

Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	Diatance	G _a Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1420	-41.63	2.98	3	8.68	-35.93	-13.00	22.93	H
2130	-45.59	3.65	3	10.52	-38.72	-13.00	25.72	H
1420	-42.20	2.98	3	8.68	-36.50	-13.00	23.50	V
2130	-50.03	3.65	3	10.52	-43.16	-13.00	30.16	V

LTE FDD Band 17_Channel Bandwidth 10MHz_QPSK_High Channel

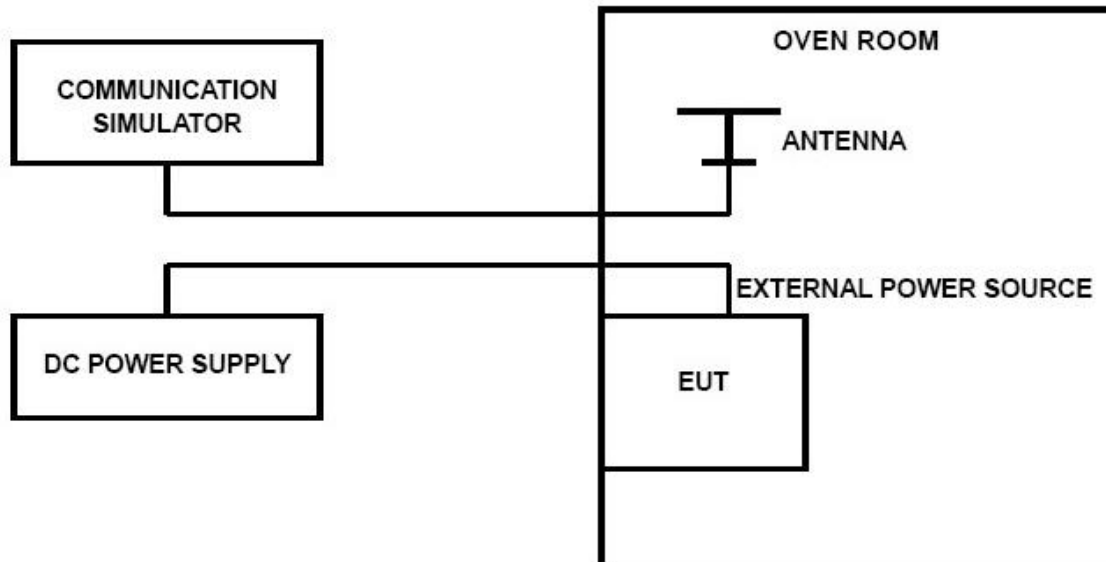
Frequency (MHz)	P _{Mea} (dBm)	P _{cl} (dB)	Diatance	G _a Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1422	-42.02	2.98	3	8.68	-36.32	-13.00	23.32	H
2133	-45.71	3.65	3	10.52	-38.84	-13.00	25.84	H
1422	-41.54	2.98	3	8.68	-35.84	-13.00	22.84	V
2133	-46.60	3.65	3	10.52	-39.73	-13.00	26.73	V

4.7. Frequency Stability under Temperature & Voltage Variations

LIMIT

According to §27.54, §2.1055 requirement, the frequency stability shall be sufficient to ensure that the fundamental emissions stay within the authorized bands of operation and should not exceed 2.5ppm.

TEST CONFIGURATION



TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

Frequency Stability Under Temperature Variations:

In order to measure the carrier frequency under the condition of AFC lock, it is necessary to make measurements with the EUT in a “call mode”. This is accomplished with the use of R&S CMW500 DIGITAL RADIO COMMUNICATION TESTER.

1. Measure the carrier frequency at room temperature.
2. Subject the EUT to overnight soak at -30°C.
3. With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call on middle channel for LTE band 4, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
4. Repeat the above measurements at 10°C increments from -30°C to +50°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements.
5. Re-measure carrier frequency at room temperature with nominal voltage. Vary supply voltage from minimum voltage to maximum voltage, in 0.1Volt increments re-measuring carrier frequency at each voltage. Pause at nominal voltage for 1.5 hours unpowered, to allow any self-heating to stabilize, before continuing.
6. Subject the EUT to overnight soak at +50°C.
7. With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call on the centre channel, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
8. Repeat the above measurements at 10 °C increments from +50°C to -30°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements
9. At all temperature levels hold the temperature to +/- 0.5°C during the measurement procedure.

Frequency Stability Under Voltage Variations:

Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation (±15%) and endpoint, record the maximum frequency change.

TEST RESULTS

Remark:

1. We tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 17; recorded worst case.

LTE Band 17, 5 MHz bandwidth (worst case of all bandwidths) at 1RB#0 for Mid channel

Frequency Error vs Voltage

Voltage (V)	Frequency error (Hz)		Frequency error (ppm)		Limit (ppm)
	QPSK	16QAM	QPSK	16QAM	
3.40	-8.65	-9.68	-0.012	-0.014	2.50
3.80	7.16	-8.56	0.010	-0.012	2.50
4.20	5.26	9.15	0.007	0.013	2.50

Frequency Error vs Temperature

Temperature (°C)	Frequency error (Hz)		Frequency error (ppm)		Limit (ppm)
	QPSK	16QAM	QPSK	16QAM	
-30°	7.62	-9.82	0.011	-0.014	2.50
-20°	-8.26	10.26	-0.012	0.014	2.50
-10°	5.72	9.85	0.008	0.014	2.50
0°	-9.35	10.35	-0.013	0.015	2.50
10°	-6.28	8.65	-0.009	0.012	2.50
20°	-6.18	-9.67	-0.009	-0.014	2.50
30°	9.35	-10.25	0.013	-0.014	2.50
40°	7.62	-8.63	0.011	-0.012	2.50
50°	8.19	-16.21	0.012	-0.023	2.50

5. Test Setup Photos of the EUT



6. External and Internal Photos of the EUT

Reference to the test report No. GTS20191021009-1-1-1

.....**End of Report**.....